

HDO6000 High Definition Oscilloscopes 350 MHz - 1 GHz



Key Features

- 12-bit ADC resolution, up to
 15-bit with enhanced resolution
- 350 MHz, 500 MHz, and
 1 GHz bandwidths
- Long Memory up to 250 Mpts/Ch
- 12.1" touch screen display
- WaveScan Advanced Search and Find
- LabNotebook Documentation and Report Generation
- History Mode Waveform Playback
- Spectrum Analyzer Mode
- Power Analyzer Option
- Serial Data Trigger, Decode and Debug Toolkit
- Unique Analysis and Application Packages
- Advanced Triggering with TriggerScan and Measurement Trigger

Combining Teledyne LeCroy's HD4096 high definition 12-bit technology, with long memory, a compact form factor, 12.1" touch screen display and powerful measurement and analysis tools, the HDO6000 is the ideal oscilloscope for circuit validation, system debug and waveform analysis. The powerful feature set provides analytical tools and unique application packages to streamline the testing process. Tools such as WaveScan Search and Find and History Mode, combined with advanced triggering, identify and isolate problems while Spectrum Analyzer Mode provides analysis tools in the frequency domain.

HD4096 Technology

HD4096 high definition technology consists of high sample rate 12-bit ADCs, high signal-to-noise input amplifiers and a low-noise system architecture. This technology enables high definition oscilloscopes to capture and display signals of up to 1 GHz with high sample rate and 16 times more resolution than other oscilloscopes.

Long Memory

With up to 250 Mpts of memory the HDO6000 High Definition Oscilloscopes can capture large amounts of data with more precision than other oscilloscopes. The 2.5 GS/s, 250 Mpts architecture provides the ability to capture a fast transient or a long acquisition.

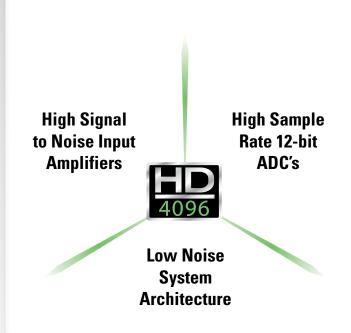
Large 12.1" Touch Screen

Navigating complicated user interfaces is a thing of the past thanks to the large touch screen display of the HDO6000. The user interface was designed for touch screens which makes navigating the HDO6000 extremely intuitive.

Comprehensive Analysis Tools

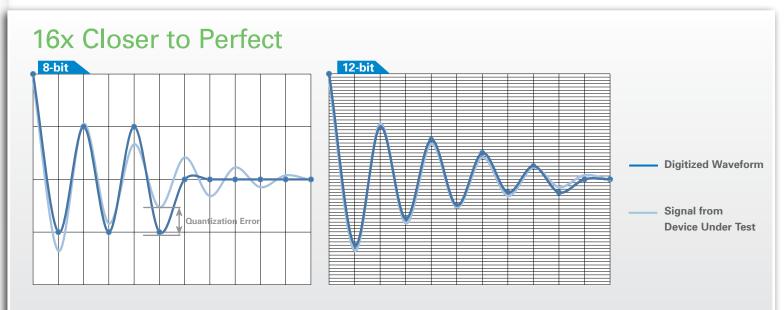
Advanced math and measurement parameters quantify waveforms while tracks, trends and histograms show how they change over time. Advanced triggering with TriggerScan and Measurement Trigger ensure even the most complicated signals are captured.

HD4096 HIGH DEFINITION TECHNOLOGY



HD4096 high definition technology consists of high sample rate 12-bit ADCs, high signal-to-noise ratio amplifiers and a low-noise system architecture. This technology enables high definition oscilloscopes to capture and display signals of up to 1 GHz with high sample rate and 16 times more resolution than other oscilloscopes.

Oscilloscopes with HD4096 technology have higher resolution and measurement precision than 8-bit alternatives. The high sample rate 12-bit ADCs provide high resolution sampling at up to 2.5 GS/s. The high performance input amplifiers deliver phenomenal signal fidelity with a 55 dB signal-to-noise ratio and provide a pristine signal to the ADC to be digitized. The low-noise signal architecture ensures that nothing interferes with the captured signal and the oscilloscope displays a waveform that accurately represents the signals from the device under test.



16x More Resolution

12-bits of vertical resolution provides sixteen times more resolution than 8-bits. The 4096 discrete levels reduce the quantization error. Signals captured with lower resolution oscilloscopes have a higher level of quantization error resulting in less accurate waveforms on the display. Signals captured on an oscilloscope with 12-bit HD4096 technology are accurately displayed with minimal quantization error.

DEBUG IN HIGH DEFINITION WITH HD4096



Oscilloscopes with HD4096 have a variety of benefits that allow the user to debug in high definition. Waveforms displayed by high definition oscilloscopes are cleaner and crisper. More signal details can be seen and measured; these measurements are made with unmatched precision resulting in better test results and shorter debug time.

Clean, Crisp Waveforms

When compared to waveforms captured and displayed by 8-bit oscilloscopes, waveforms captured with HD4096 technology are dramatically crisper and cleaner.

Oscilloscopes with HD4096 acquire waveforms at high resolution, high sample rate and low noise to display the most accurate waveforms.

More Signal Details

Signal details often lost in the noise are clearly visible and easy to distinguish when captured on oscilloscopes with HD4096. Details which were previously difficult to even see can now be easily seen and measured. Using the oscilloscope zoom capabilities gives an even closer look at the details for unparalleled insight to the signals on screen.

Unmatched Measurement Precision

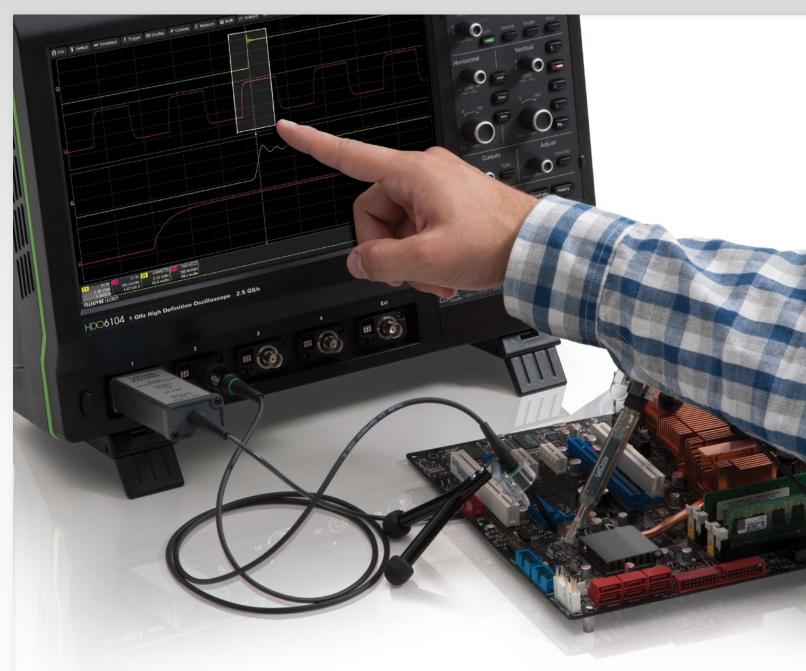
Precise measurements are critical for effective debug and analysis. HD4096 enables oscilloscopes to deliver unmatched measurement precision to improve testing capabilities and provide better results.



- Clean, Crisp Waveforms | Thin traces show the actual waveform with minimal noise interference
- B More Signal Details | Waveform details lost on an 8-bit oscilloscope can now be clearly seen
- Unmatched Measurement Precision | Measurements are more precise and not affected by quantization noise

TOUCH SCREEN SIMPLICITY



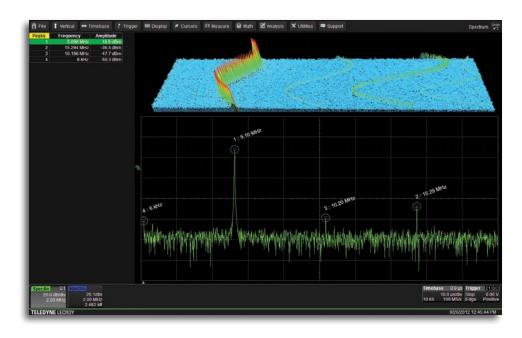


Don't waste time searching through a complex menu structure to find the proper setting. Configuring the HDO6000 is simple thanks to the intuitive touch screen user interface. Everything on the screen is interactive. To adjust channel, timebase, or trigger settings, simply touch the associated descriptor box and the appropriate menu is

opened. Measurements can be touched to adjust their settings and cursors can be positioned precisely by touching and dragging them to the proper location. A box can be drawn around a portion of a waveform to create a zoom of that waveform. Even waveform offset and delay can be adjusted simply by touching and dragging the waveform.

ADVANCED TOOLS FOR WAVEFORM ANALYSIS





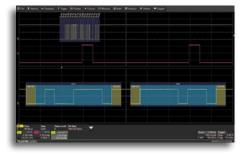
Spectrum Analyzer Mode

View the frequency content of signals with spectrum analyzer style controls, easily adjust the frequency span, resolution bandwidth and center frequency. A unique peak search detects spectral components and presents frequency and level details in an interactive table. Use the spectrogram display to see changes in the spectrum over time.



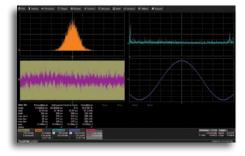
WaveScan Advanced Search and Find Tool

Quickly search waveforms for anomalies, use analysis tools to graph the results or trigger on outliers.



Serial Bus Trigger and Decode

View protocol information on top of physical waveforms, trigger on messages, extract and graph data to monitor system performance.



Advanced Analysis Tools

Perform jitter and timing measurements, filter signals, and create custom math and measurement functions to solve the most challenging problems.

Sequence Mode Acquisition

Capture many fast pulses in quick succession or events separated by long periods of time.

History Mode Waveform Playback

Scroll back in time to isolate anomalies that have previously been captured to quickly find the source of the problem.

LabNotebook Documentation and Report Generation Tool

Save all results and data with a single button press and create custom reports with LabNotebook.

HDO6000 - HIGH DEFINITION OSCILLOSCOPE



HDO6000 High Definition Oscilloscopes combine Teledyne LeCroy's HD4096 high definition technology with long memory and powerful debug tools in a compact form factor with a 12.1" touch screen display.

- Only 13 cm (5") Deep The most space-efficient oscilloscope for your bench from 200 MHz to 1 GHz
- 12.1" Widescreen (16 x 9) high resolution WXGA color touch screen display. The most time-efficient user interface is even easier to use with a built-in stylus
- Local language user interface Select from 10 language preferences. Add a front panel overlay with your local language
- "Push" Knobs All knobs have push functionality that provides shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay









- Waveform Control Knobs Control channel, zoom, math and memory traces with the multiplexed vertical and horizontal knobs
- **6.** Dedicated Cursor Knob Select type of cursor, position them on your signal, and read values without ever opening a menu
- Dedicated buttons to quickly access popular debug tools.
- **8.** Easy connectivity with two convenient USB ports on the front, two on the side
- Rotating and Tilting Feet provide 4 different viewing positions
- Auxiliary Output and Reference Clock Input/Output connectors for connecting to other equipment
- **11.** USBTMC (Test and Measurement Class) port simplifies programming



Document and Share:

- Quickly save all files with LabNotebook
- Create custom reports with LabNotebook
- Save to internal solid state or network drive
- Print to a USB printer
- Save to USB memory stick
- Connect with LAN or GPIB
- View data on a PC with free WaveStudio utility

IDENTIFY AND ISOLATE PROBLEMS FASTER





WaveScan Advanced Search

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan provides the ability to locate unusual events in a single capture (i.e., capture and search), or "scan" for an event in many acquisitions over a long period of time with more than 20 search modes.

Since the scanning "modes" are not simply copies of the hardware triggers, the utility and capability is much higher. For instance, there is no "frequency" trigger in any oscilloscope, yet WaveScan allows for "frequency" to be quickly "scanned." This allows the user to accumulate a data set of unusual events that are separated by hours or days, enabling faster debugging. When used in multiple

acquisitions, WaveScan builds on the traditional Teledyne LeCroy strength of fast processing of data. Quickly scan millions of events looking for unusual occurrences, and do it much faster and more efficiently than other oscilloscopes can. Found events can be overlaid with the ScanOverlay to provide a quick comparison of events; measurement based scans populate the ScanHistogram to show the statistical distribution of the events.

Advanced Waveform Capture with Sequence Mode

Use Sequence mode to store up to 65,000 triggered events as "segments" into memory. This can be ideal when capturing many fast pulses in quick succession or when capturing events separated by long time periods.

Sequence mode provides timestamps for each acquisition and minimizes dead-time between triggers to less than 1 µs. Combine Sequence mode with advanced triggers to isolate rare events over time and analyze afterwards.

Advanced Math and Measure

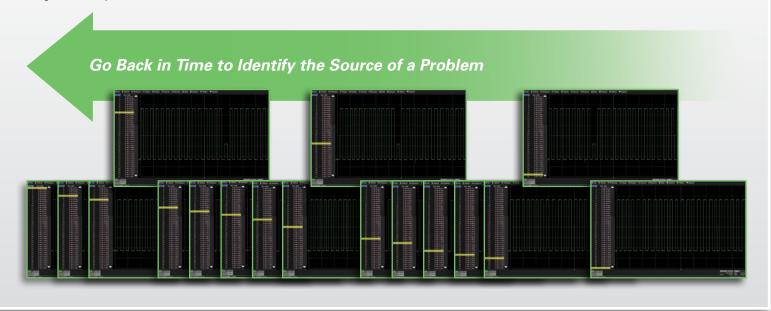
With math functions including averaging, enhanced resolution and FFT plus a wide variety of measurement parameters the HDO6000 can measure and analyze every aspect of a waveform. By utilizing HD4096 technology, the HDO6000 measures 16 times more precisely than traditional 8-bit architectures. Beyond just measuring waveforms, the HDO6000 provides statistics, histicons and trends to show how waveforms change over time.





History Mode Waveform Playback

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.



LabNotebook

The LabNotebook feature of HDO6000 provides a report generation tool to save and document all your work. Saving all displayed waveforms, relevant settings, and screen images is all done through LabNotebook, eliminating the need to navigate multiple menus to save all these files independently.



Flashback capability.

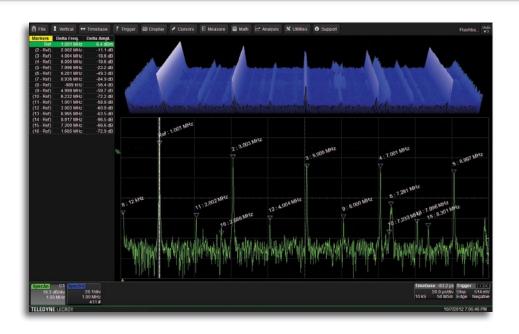
single button press.

SPECTRUM ANALYZER MODE



Key Features

- Spectrum analyzer style controls for the oscilloscope
- Select from six vertical scales
- Automatically identify frequency peaks
- Display up to 20 markers, with interactive table readout of frequencies and levels
- Easily make measurements with reference and delta markers
- Automatically identify and mark fundamental frequency and harmonics
- Spectrogram shows how spectra changes over time in 2D or 3D views



Simplify Analysis of FFT Power Spectrum

Get better insight to the frequency content of any signal with use of the Spectrum Analyzer mode on the HDO6000. This mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Vertical Scale can be selected as dBm, dBV, dBmV, dBuV, Vrms or Arms for proper viewing and analysis while the unique peak search automatically labels spectral components and presents frequency and level in an interactive table. Utilize up to 20 markers to automatically identify harmonics and quickly analyze frequency content by making measurements between reference and delta markers. To monitor how the spectrum changes over time, view the spectrogram which can display a 2D or 3D history of the fequency content.



Spectrum analyzer style controls simplify waveform analysis in the frequency domain.

POWER ANALYZER OPTION





Key Features

- Quickly analyze power conversion circuits
- Automatic switching device measurements
- Color coded overlay to identify power losses
- Control loop and time domain response analysis
- Line power and harmonics tests to IEC 61000-3-2

Power Analyzer Automates Switching Device Loss Measurements

Quickly measure and analyze the operating characteristics of power conversion devices and circuits with the Power Analyzer option. Critical power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements. Areas of turn-on, turn-off, and conduction loss are all identified with color-coded waveform overlays for faster analysis.

Power Analyzer provides quick and easy setup of voltage and current inputs and makes measurements as simple as the push of a button. Tools are provided to help reduce sources of measurement errors and the measurement parameters provide details of single cycle or average device power losses.

Beyond the advanced power loss measurement capabilities,

the Power Analyzer modulation analysis capabilities provide insight to understand control loop response to critical events such as a power supply's soft start performance or step response to line and load changes. The Line Power Analysis tool allows simple and quick pre-compli-

ance testing to EN 61000-3-2.

e cycle or average device power losses.

neasurement capabilities,

allysis

Teledyne LeCroy has a variety of probes and probing accessories such as high common mode rejection ratio (CMRR) differential amplifiers, differential probes, current probes, and deskew fixtures.

SERIAL TRIGGER AND DECODE OPTIONS



Debugging serial data busses can be confusing and time consuming. The serial data trigger and decode options for HDO6000 provide time saving tools for serial bus debug and validation.

Protocol triggering quickly identifies and captures key messages on the bus while the color-coded overlay decodes it for simple debugging. Long memory in the HDO enables the capture of many serial data packets, sorting through these packets is easy with the interactive decode table and convenient protocol specific search function.

Supported Protocols

- I2C, SPI, UART
- CAN, LIN, FlexRay™, SENT
- USB 1.0/1.1/2.0, USB 2.0-HSIC
- Audio (I²S, LJ, RJ, TDM)
- MIL-STD-1553, ARINC 429
- MIPI D-PHY, DigRF 3G, DigRF v4



View decoded protocol information on top of physical layer waveforms and trigger on protocol specific messages.

Trigger

The serial data trigger will quickly isolate events on a bus eliminating the need to set manual triggers and hoping to catch the right information.

Trigger conditions can be entered in binary or hexadecimal formats and conditional trigger capabilities even allow triggering on a range of different events.

Decode

Protocol decoding is shown directly on the waveform with an intuitive, color-coded overlay and presented in binary, hex or ASCII. Decoding on the HDO6000 is fast even with long memory and zooming in to the waveform shows precise byte by byte decoding.

Table

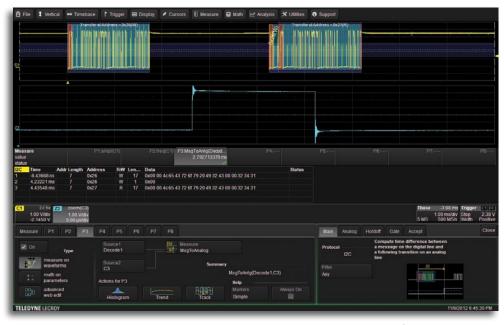
To further simplify the debug process all decoded data can be displayed in a table below the waveform grid. Selecting an entry in the table with the touch screen will display just that event. Additionally, built-in search functionality will find specific decoded values.

Search

Serial data messages can be quickly located by searching on address, data and other attributes specific to a particular protocol.

SERIAL DATA DEBUG TOOLKIT





The PROTObus MAG (measure, analysis, graph) Serial Debug Toolkit significantly extends the trigger and decode functionalities of tthe HDO by providing tools for more complete and faster validation and debugging of embedded designs. It provides the deepest level of insight possible.

Use the Message to Analog measurement to find the time between an l^2C data packet and a control signal on another channel. Measurement gates and filtering help to control the measurement packet under test to eliminate any confusion with setup.

Data Extraction and Graphing Tools

Extract data from the serial protocol message stream and use the track functions to graphically plot that data on the oscilloscope display. The digital data is used to create an analog waveform that can then be compared to other electrical signals.

Timing and Bus Measurements

Specific measurement parameters allow you to quickly and easily characterize your serial data system and make gateway measurements. Use the Message-Message parameter to find the time between two messages on the bus or the Message-Analog parameter to correlate bus traffic to an analog signal. Use measurement statistics and histicons to understand the range of measurements on the protocol bus.

Easy Measurement Setup

Easily configure the proper measurement with large descriptive icons, helpful descriptions, and measurement markers to make sure the measurement is made properly. Apply a filter to any measurement for more accurate results. Identify a specific ID or ID and Data using the powerful conditional setup for more accurate filtering.

Compatibility

The Protobus MAG serial debug toolkit works with I²C, SPI, UART, CAN, LIN, FlexRay, DigRF 3G, DigRF v4, ARINC429 and MIL-STD-1553 decoders.

Bus Status Measurements

Quickly get an overall status of the bus being probed to learn if it is over utilized and bit rate matches expectations.

Debug Tools Include:

- Extract data from serial bus
- Graph data as analog waveform
- Measure time between messages and other events
- Measure bus performance with bit rate and bus load parameters

PROBES



The right probe is an essential tool for accurate signal capture and Teledyne LeCroy offers an extensive range of probes to meet virtually every probing need.

ZS Series High Impedance Active Probes

ZS2500, ZS1500, ZS1000, ZS2500-QUADPAK, ZS1500-QUADPAK, ZS1000-QUADPAK



The ZS Series probes provide high impedance and an extensive set of probe tips and ground accessories to handle a wide range of probing scenarios. The high 1 $\mbox{M}\Omega$ input resistance and low 0.9 pF input capacitance mean this probe is ideal for all frequencies. The ZS Series probes provide full system bandwidth for all Teledyne LeCroy oscilloscopes having bandwidths of 1 GHz and lower.

Differential Probes (200 MHz-1.5 GHz) ZD1500, ZD1000, ZD500, ZD200



High bandwidth, excellent common-mode rejection ratio (CMRR) and low noise make these active differential probes ideal for applications such as automotive development (e.g. FlexRay) and failure analysis, as well as wireless and data communication design. The ProBus interface allows sensitivity, offset and common-mode range to be displayed on the oscilloscope screen.

High Voltage Differential Probes ADP305, ADP300, AP031



Low cost active differential probes are intended for measuring higher voltages. The differential techniques employed permit measurements to be taken at two points in a circuit without reference to the ground, allowing the oscilloscope to be safely grounded without the use of opto-isolators or isolating transformers.

High Voltage Passive Probes PPE1 2KV PPE20KV

PPE1.2KV, PPE20KV, PPE2KV, PPE4KV, PPE5KV, PPE6KV



The PPE Series includes five fixed-attenuation probes covering a range from 2 kV to 20 kV, and one switchable probe providing ÷10/÷100 attenuation for voltage inputs up to 1.2 kV. All fixed-attenuation, standard probes automatically rescale compatible Teledyne LeCroy oscilloscopes for the appropriate attenuation of the probe.

Current Probes

CP031, CP030, AP015, CP150, CP500, DCS015



Available current probes reach bandwidths of 100 MHz, peak currents of 700 A and sensitivities of 10 mA/div. Use multiple current probes to make measurements on three-phase systems or a single current probe with a voltage probe to make instantaneous power measurements. Teledyne LeCroy current probes enable the design and testing of switching power supplies, motor drives, electric vehicles, and uninterruptible power supplies.



	HDO6034	HDO6054	HDO6104
Vertical			
Bandwidth @ 50 Ω (-3 dB)	350 MHz	500 MHz	1 GHz
Ballawiati e ee al (e ab)	335 1411 12	000 1411 12	1 31.2
Rise Time (10–90%, 50 Ω)	1 ns typical	700 ps typical	450 ps typical
Input Channels	4		
Vertical Resolution	12-bits; up to 15-bits with enhanced re-	solution (ERES)	
Sensitivity	50 Ω : 1 mV/div–1 V/div, fully variable 1 M Ω : 1 mV/div–10 V/div, fully variable		
DC Gain Accuracy (Gain Component of DC Accuracy)	±(0.5%) F.S, offset at 0 V		
Bandwidth Limiters	20 MHz, 200 MHz		
Maximum Input Voltage	50 Ω : 5 Vrms, 1 M Ω : 400 V max (DC +	Peak AC ≤ 10 Khz)	
Input Coupling	50 Ω : DC, GND; 1 M Ω : AC, DC, GND;		
Input Impedance	50 Ω ± 2.0%;1 M Ω ± 2.0% 15 pF,		
Offset Range	50 Ω : 1 mV - 4.95 mV: \pm 1.6 V, 5 mV - 9 1 M Ω : 1 mV - 4.95 mV: \pm 1.6 V, 5 mV - 9 102 mV - 198 mV: \pm 80V, 200 mV		
DC Vertical Offset Accuracy	\pm (1.0% of offset value + 0.5%FS + 0.0	02% of max offset + 1mV)	
Acquisition			
Sample Rate (Single-shot)	2.5 GS/s		
Sample Rate (Repetitive)	125 GS/s, user selectable for repetitive		
Record Length	Standard -STD: 50 Mpts/ch (all channe Option - L: 100 Mpts/ch (all chann Option -XL: 250 Mpts/ch (all chann	els)	
Acquisition Modes	Real-time, Roll, RIS (Random Interleave Sequence (Segmented Memory up to 3 with 1us intersegment dead-time		L Option, 65,000 -XL option)
Timebase Range	Real-Time: 20 ps/div-1000 s/div; RIS m Roll mode: up to 1000 s/div (roll mode		l ≤ 5 MS/s
Timebase Accuracy	±2.5 ppm for 5 to 40C + 1.0ppm/year		
Channel-Channel Deskew Range	±9 x time/div. setting, 100 ms max., ea	ach channel	
External Timebase Reference (Input)	10 MHz ±25 ppm at 0 to 10 dBm into §	50 Ω	
External Timebase Reference (Output)	10 MHz 2.0 dBm ±1 dBm, sinewave sy	·	
External Clock	DC to 100 MHz; (50 Ω /1 M Ω), Ext. BNO Minimum rise time and amplitude requ	C input, irements apply at low frequencies	
Acquisition Processing			
Averaging	Summed averaging to 1 million sweeps	s; continuous averaging to 1 million s	Weeps
Enhanced Resolution (ERES)	From 12.5- to 15-bits vertical resolution		<u>'</u>
Envelope (Extrema)	Envelope, floor, or roof for up to 1 million		
Interpolation	Linear (Default) or Sin x/X	011 011 0000	
merpolation	Linear (Bordard of Sill My)		
Triggering System	_		
Modes	Auto, Normal, Single, Stop		
Sources	Any input channel, External, Ext/10, or	line; slope and level unique to each s	ource (except for line trigger)
Coupling	DC, AC, HFREJ, LFREJ		
Pre-trigger Delay	0-100% of memory size		
Post-trigger Delay	0-10,000 Divisions in real time mode, li		n roll mode
Hold-off	From 2 ns up to 20 s or from 1 to 99,99	99,999 events	
Internal Trigger Level Range	±4.1 div from center (typical)		
External Trigger Input Range	Ext: ±400 mV, Ext/10: ±4 V	4. 4	
Maximum Trigger Rate	1M Triggers/sec (in Sequence Mode, u	up to 4 channels)	



	HDO6034	HDO6054	HDO6104
Triggering System (cont')			
Trigger Sensitivity with Edge Trigger (Ch 1–4)	0.9 division: 10 MHz 1.0 divisions: 200 MHz 2.0 divisions: 350 MHz	0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 250 MHz 2.0 divisions: 500 MHz	0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 500 MHz 2.0 divisions: 1 GHz
External Trigger Sensitivity, (Edge Trigger)	0.9 division: 10 MHz 1.0 divisions: 200 MHz 2.0 divisions: 350 MHz	0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 250 MHz 2.0 divisions: 500 MHz	0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 500 MHz 2.0 divisions: 1 GHz
Max. Trigger Frequency, (C1-C4, Aux In, Smart Trigger)	350 MHz	500 MHz	1 GHz
Trigger and Interpolator Jitter	≤ 3.5 ps rms (typical) <0.1 ps rms (typical, software assiste	d)	
Trigger Types			
Edge	Triggers when signal meets slope (pos	sitive negative or either) and level co	ondition
Width (Signal or Pattern)	Triggers on positive or negative glitches with selectable widths selectable as low as 200 ps (depending on oscilloscope bandwidth); Maximum Width: 20 s		
Pattern	Logic combination (AND, NAND, OR, NOR) of 5 inputs (4 channels and external trigger input). Each source can be high, low, or don't care. The High and Low level can be selected independently. Triggers at start or end of the pattern		
Measurement Trigger	Trigger on Measurement with qualified limits.		
TV-Composite Video	Triggers NTSC or PAL with selectable HDTV (720p, 1080i, 1080p) with selectable Fields (1–8). Interlacing (1:1, 2:1, 4:1, 8:1), or Syncl	line and field; stable frame rate (50 or 60 Hz) and Lin , Lines (up to 2000), Frame Rates (25,	
Smart Triggers	<u> </u>		
Window	Triggers when signal exits a window of	defined by adjustable thresholds	
Interval (Signal or Pattern)	Triggers on intervals selectable betwe	en 1 ns and 20 s	
Glitch	Triggers on positive or negative glitche bandwidth) to 20 s, or on intermittent		00 ps (depending on oscilloscope
Dropout	Triggers if signal drops out for longer t	than selected time between 1 ns and	20 s
Runt	Trigger on positive or negative runts d Select between 1 ns and 20 ns	efined by two voltage limits and two	time limits.
Slew Rate	Trigger on edge rates. Select limits for	r dV, dt, and slope. Select edge limits	between 1 ns and 20 ns
Multi-Stage Triggers			
Cascade (Sequence) Triggering			
Capability	Arm on "A" event, then Trigger on "B "C" event. Or Arm on "A" event, the	n Qualify on "B" then "C" event, and	d Trigger on "D" event
Types	A, B, C, or D event: Edge, Glitch, Widor Measurement.	th, Window, Dropout, Interval, Runt, S	Slew Rate, Pattern (analog),
Holdoff	Holdoff between A and B, B and C, C	or D, or any is selectable by time or r	number of events
Qualified First	In Sequence acquisition mode, trigger satisfied in the first segment of the ac		ned pattern, state, or edge (event A) is selectable by time or events
Qualified	Triggers on any input source only if a conclusion Delay between sources is selectable by	by time or events	·
TriggerScan	A Trigger Trainer analyzes the waveforms, identifies normal behavior, and then sets up a large set of rare event smart trigger setups that target abnormal behavior. The trainer 'learns' trigger setups based on slew rates, periods, amplitudes outside of a range and then applies them sequentially.		
Triggers with Exclusion Technology	Glitch, Width, Interval, Runt, Slew Rat triggering when that condition is not r		pecifying the expected behavior and



	HDO6034	HDO6054	HDO6104
Measurement Tools			
Measurement Functionality	Histicons provide a fast, dynamic vie Parameter Math allows addition, sub Parameter gates define the location of	ith statistics, including their average, have of parameters and wave shape char traction, multiplication, or division of two the source waveform.	acteristics. wo different parameters.
Measurement Parameters	80–20%, @ level), Frequency, First, L Narrow band power, Number of poin 20–80%, @ level), RMS, Std. deviatio (max.), Delta time @ level, Delta tim Cycle with start selection, Frequency	Data, Delay, Delta Delay, Duty Cycle, ast, Level @ x, Maximum, Mean, Meats, + Overshoot, Peak-to- un, Top, Width, Median, Phase, Time @ e @ level from trigger, X @ max., X @ e @ level, Period @ level, Half Period, V @ level, Duty Cycle Error, Edge @ lv (c	dian, Minimum, Narrow band phase, -peak, Period, Risetime (10–90%, Diminimum (min.), Time @ maximum min., Cycle-Cycle Jitter, N-Cycle, N- Vidth @ level, Time Interval Error @
Math Tools			
Math Functionality	operations on each function trace, an	(F1–F8). The easy-to-use graphical inte d function traces can be chained toge:	ther to perform math-on-math.
Math Operators	Derivative, Deskew (resample), Diffe Exp (base 10), FFT (power spectrum, to 128 Mpts and rectangular, VonHal polate (cubic, quadratic, sinx/x), Inverunits), Roof, (SINx)/x, Sparse, Square be defined at a time.	Average (continuous), Correlation (two rence (-), Enhanced resolution (to 15 k magnitude, phase, power density, reann, Hamming, FlatTop and Blackman Ft (negate), Log (base 10), Square root, Sum (+), Zoom (identity)	oits vertical), Envelope, Exp (base e), al, imaginary, magnitude squared, up darris windows), Floor, Integral, Inter- , Product (x), Reciprocal, Rescale (with
Measurement and Math Into	egration		
	Histograms expanded with 19 histog Trend (datalog) of up to 1 million ever Track graphs of all parameters Persistence histogram, persistence t		ents
Pass/Fail Testing			
Test Types	Parameter limit testing, mask testing Pass/Fail Actions include: Save, Stop	Alarm, Pulse, Hardcopy, LabNoteboo	k
Probes			
Standard Probes	One PP018 (5 mm) per channel		
Probing System	BNC and Teledyne LeCroy ProBus fo	r Active voltage, current and differentia	al probes
Display System			
Display Size	Color 12.1" widescreen flat panel TFT	-Active Matrix with high resolution tou	uch screen
Display Resolution	WXGA; 1280 x 800 pixels		
Number of Traces		ultaneously display channel, zoom, m	
Grid Styles		Single+X-Y, Dual+X-Y, Tandem, Quattro	o, Twelve, Sixteen
Waveform Representation	Sample dots joined, or sample dots of	nly	
Connectivity			
Ethernet Port	(2) 10/100/1000Base-T Ethernet inter	face (RJ-45 connector)	
USB Host Ports	(6) USB Ports Total – (2) Front USB P	orts	
USB Device Port	(1) USBTMC Port		
GPIB Port (Optional)	Supports IEEE – 488.2 (External)		
External Monitor Port		tible DB-15 connector, DVI connector	and HDMI connector
Remote Control	Via Windows Automation, or via Tele	dyne LeCroy Remote Command Set	
Processor/CPU			
Туре	Intel Core i5, 2.5 GHz (or better)		
Processor Memory	4 GB standard		
Operating System	Windows® Embedded Standard 7 Pro	otessional, 64-bit	
Disk Type	Solid State Drive 64 GB (or better)		



	HDO6034	HDO6054	HDO6104	
Power Requirements				
Voltage	100–240 VAC ±10% at 45–66 Hz; 100–120 VAC ±10% at 380–420 Hz; Automatic AC Voltage Selection; Installation Category: 300 V CAT II			
Power Consumption (Nominal)	200 W / 200 VA			
Max Power Consumption	350 W / 350 VA (with all PC peripherals and active probes connected to 4 channels)			
Environmental				
Temperature	Operating: 5 °C to 40 °C; Non-Opera	ting: -20 °C to 60 °C		
Humidity	Operating: 5% to 90% relative humidity (non-condensing) up to +31 °C, Upper limit derates to 50% relative humidity (non-condensing) at +40 °C; Non-Operating: 5% to 95% relative humidity (non-condensing) as tested per MIL-PRF-28800F			
Altitude	Operating: 3,048 m (10,000 ft) max at ≤ 30C; Non-Operating: Up to 12,192 meters (40,000 ft)			
Random Vibration		15 minutes in each of three orthogonal Hz, 15 minutes in each of three orthog		
Functional Shock	30 g _{peak} , half sine, 11 ms pulse, 3 shock	s (positive and negative) in each of three o	orthogonal axes, 18 shocks total	
Physical				
Dimensions (HWD)	11.48"H x 15.72"W x 5.17"D (291.7	mm x 399.4 mm x 131.31 mm)		
Weight	5.86 kg (12.9 lbs)			
Certifications				
CE Certification	Low Voltage Directive 2006/95/EC EN 61010-1:2010, EN 61010-2-030:2	010		
	EMC Directive 2004/108/EC EN 61326-1:2006, EN61326-2-1:2006	5		
UL and cUL Listing	UL 61010-1 (3rd Edition), UL 61010-2 CAN/CSA C22.2 No.61010-1-12	2-030 (1st Edition)		
Warranty and Service				
	3-year warranty; calibration recomme upgrades, and calibration services	ended annually. Optional service progra	ms include extended warranty,	

ORDERING INFORMATION

LIN Trigger and Decode Option

CAN Bus Trigger, Decode &

Measure/Graph Option

CAN TD Trigger and Decode Option



Product Description	Product Code		duct Code
HDO6000 Oscilloscopes		Serial Data Options (cont'd)	
350 MHz, 2.5 GS/s, 4 Ch, 50 Mpts/Ch 12-bit HD	HDO6034		xRaybus TD
Oscilloscope with 12.1" WXGA Touch Display		FlexRay Bus Trigger, Decode, and HDO6K-Flex	Raybus TDP
500 MHz, 2.5 GS/s, 4 Ch, 50 Mpts/Ch 12-bit HD	HDO6054	Physical Layer Test Option	
Oscilloscope with 12.1" WXGA Touch Display			-SENTbus D
1 GHz, 2.5 GS/s, 4 Ch, 50 Mpts/Ch 12-bit HD	HDO6104		6K-1553 TD
Oscilloscope with 12.1" WXGA Touch Display		ARINC 429 Symbolic Decode Option HDO6K-ARINC429bus	
Included with Standard Configuration			JSB2bus TD
÷10 PP018 Passive Probe (Total of 1 Per Channel), Get	ting Started Guide	USB2-HSIC Decode Option HD06K-USB2	
Anti-virus Software (Trial Version), Microsoft Windows		tion to the second seco	DPHYbus D
7 P 64-Bit License, Commercial NIST Traceable Calibra			RF3Gbus D
Certificate, Power Cable for the Destination Country, 3	-year Warranty		gRFv4bus D
Memory Options		I ² S, LJ, RJ, and TDM	Audiobus TD
100 Mpts/CH (50 Mpts interleaved) memory	HDO6K-L		diobus TDG
250 Mpt/Ch Memory Option	HDO6K-XL		otoBusMag_
			HDO6K-VBA
Hardware Options		TDM, CAN Symbolic, FlexRay TDP, LIN TD	
Removable Solid State Drive Package (includes	HDO6K-RSSD	and Protobus MAG.	
removable solid state drive kit and two hard drives	LIDOOK DOOD OO	Dueline and Assert Com-	
Additional Removable Solid State Drive	HDO6K-RSSD-02	Probes and Amplifiers	
General Accessories		500 MHz Passive Probe, 10:1, 10 MOhm	PP018
External GPIB Accessory	USB2-GPIB	Set of 4 ZS1500, 1.5 GHz, 0.9 pF, 1 M Ω ZS1500 High Impedance Active Probe	D-QUADPAK
Soft Carrying Case	HDO6K-SOFTCASE		D-QUADPAK
Rack Mount Accessory	HDO6K-RACK	High Impedance Active Probe	FQUADFAK
Accessory Pouch	HDO6K-POUCH	200 MHz, 3.5 pF, 1 M Ω Active Differential Probe	ZD200
7.10000001, 7.0001.	1120011100011	500 MHz, 1.0 pF, 1 MΩ Active Differential Probe	ZD500
Local Language Overlays		1 GHz, 1.0 pF, 1 M Ω Active Differential Probe	ZD1000
German Front Panel Overlay HD	006K-A-FP-GERMAN	1.5 GHz, 1.0 pF, 1 M Ω Active Differential Probe	ZD1500
French Front Panel Overlay H	DO6K-A-FP-FRENCH	1,400 V, 100 MHz High-Voltage Differential Probe	ADP305
Italian Front Panel Overlay	HDO6K-A-FP-ITALIAN	1,400 V, 20 MHz High-Voltage Differential Probe	ADP300
Spanish Front Panel Overlay H	DO6K-A-FP-SPANISH	1 Ch, 100 MHz Differential Amplifier	DA1855A
Japanese Front Panel Overlay HD0	D6K-A-FP-JAPANESE	with Precision Voltage Source	271100071
Korean Front Panel Overlay H	DO6K-A-FP-KOREAN	100:1 or 10:1 Selectable, 250 MHz Passive Diff. Probe Pair	DXC100A
Chinese (Tr) Front Panel Overlay HD	O6K-A-FP-CHNES-TR	30 A; 100 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse	CP031
Chinese (Simp) Front Panel Overlay HD	06K-A-FP-CHNES-SI	30 A; 50 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse	CP030
Russian Front Panel Overlay HI	006K-A-FP-RUSSIAN	30 A; 50 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse	AP015
		150 A; 10 MHz Current Probe – AC/DC; 150 A _{rms} : 500 A _{peak} Pulse	CP150
Software Options		500 A; 2 MHz Current Probe – AC/DC; 500 A _{rms} ; 700 A _{peak} Pulse	CP500
Electrical Telecom Mask Test Package	HDO6K-ET-PMT	10:1/100:1 200/300 MHz, 50 MΩ High-voltage Probe	PPE1.2KV
Power Analysis Option	HDO6K-PWR	600 V/1,2 kV Max. Volt. DC	
DFP2 Digital Filter Option	HDO6K-DFP2	100:1 400 MHz 50 MΩ 2 kV High-voltage Probe	PPE2KV
Serial Data Mask Option	HDO6K-SDM	100:1 400 MHz 50 MΩ 4 kV High-voltage Probe	PPE4KV
Clock and Clock-Data Timing Jitter Analysis Package	HDO6K-JITKIT	1000:1 400 MHz 50 MΩ 5 kV High-voltage Probe	PPE5KV
Developer's Tool Kit Option	HDO6K-XDEV	1000:1 400 MHz 50 MΩ 6 kV High-voltage Probe	PPE6KV
EMC Pulse Parameter Software Package	HDO6K-EMC	1000:1 100 MHz 50 M Ω 6 kV High-voltage Probe 20 kV Max. Volt DC + 40 kVPeak AC	PPE20KV
Serial Data Options			
I ² C, SPI and UART Trigger and Decode Option	HDO6K-EMB		
I ² C Bus Trigger and Decode Option	HDO6K-I2Cbus TD		
SPI Bus Trigger and Decode Option	HDO6K-SPIbus TD		
UART and RS-232 Trigger and Decode Option HDO6	6K-UART-RS232bus TD		
CAN, LIN and FlexRay Trigger and Decode Option	HDO6K-AUTO		

HDO6K-LINbus TD

HDO6K-CANbus TD

HDO6K-CANbus TDM

Customer Service Teledyne LeCroy oscilloscopes and probes are designed, built, and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes: • No charge for return shipping • Long-term 7-year support • Upgrade to latest software at no charge

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